

Photograph No.1 Setup for spurious emission measurements in the anechoic chamber below 30 MHz



EUT in case profile #1



Photograph No.2 Setup for carrier field strength, power spectral density, OBW and spurious emission measurements in the anechoic chamber from 30 to 1000 MHz



EUT in case profile #1



Photograph No.3 Setup for spurious emission measurements in the anechoic chamber above 1000 MHz



EUT in case profile #1



Photograph No.4 Setup for spurious emission measurements in the anechoic chamber, EUT close view



EUT in case profile #1

